Observation of nano-structure cluster formation of rare earth ions in wide band gap fluorine dielectric crystals using transmission electron microscopy with atomic resolution



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Abstract

157nm laser lithography enable the production of microelectronic circuits with dimensions below 100 nm.

Fluorides (CaF₂, SrF₂ and KY₃F₁₀), doped with trivalent rare earth ions could be used as optical elements in the vacuum ultraviolet region.

The refractive index variation of material should be lower than 10⁻⁶ =>

the optical elements should be prepared from ultra high purity materials.

Objectives

to test the homogeneity on the nano or even atomic level

Methods

Analytical Electron Microscopy J 2010 F (FEG) EDXS, HRTEM, HAADF/STEM

EDXS

- Perform sets of point analysis using different beam diameter.
- Compare the spread of the results
- > If Tm is evenly distributed:
- Re. St. Deviation of the results should be comparable depending on counting statistics, but not on beam size)
- > If Tm is forming nano-sized clusters :
- Re. St. Deviation should be inversely reciprocal to the beam diameter.

Results



Set of quantitative EDXS results obtained using 50nm beam diameter





EDXS results obtained using 2nm beam diameter

> Relative standard deviation of the measured Tm concentration Vs electron beam diameter

Spread of the results from quantitative EDXS analysis using beam diameter from 2-50nm indicates the presence of nano-meter sized region with non-uniform composition

Direct observation on atomic level

HRTEM

Procedure: Calculate the simulated images on CaF₂ with clusters present and compare the images to the experimental images.



EXPERIMENTAL



In experimental HRTEM image could be found that are similar to those for simulated images where clusters of Tm ions line precipitates) were taken into account



Simulated HAADF images for CaF₂ in [110] zone with 5 columns of Tm ions



Experimental FFT (filtered) HAADF -STEM images

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